THE SCATTER WORKS INC. GRESHAM, OREGON USA **High Speed Wafer** Roughness Measurement TMS R/C Plot [Testwaferfront.DB0] "Wafer: 200mm" Edit Options Zoom Run Help RMS (Å) Low 4.00 Total Avg 2.44 3.50 STDIN 94 3.25 3.00 2.75 250 20 2.25 2 00 1.75 1.50 1.25 1.00 0.75 0.50 2000-W ☐ Autoscale Cursor Background Radial & Circumferential Bi-directional Roughness For each data point

Front and Backside Measurements

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